Form PTO-1449	Docket Number 204552016501		Application Number NEW
INFORMATION DISCLOSURE CITATION IN AN APPLICATION *(Use several sheets if necessary)*	**Applicant** Yuichi SATO		
	Filing Date February 10, 2004		Group Art Unit
	Mailing Date February 10, 2004		

U.S. PATENT DOCUMENTS

Examiner Initials	Ref. No.	Date	Document No.	Name	Class	Subclass	Filing Date If Appropriate
〇×W	1.	7/1998	5,780,899	Hu et al.			
	2.	11/1998	5,831,899	Wang et al.			
	3.	9/1999	5,960,289	Tsui et al.			
	4.	2/2000	6,020,222	Wollesen			

FOREIGN PATENT DOCUMENTS

Examiner Initials	Ref. No.	Date	Document No.	Country	Class	Subclass	Translation YES	NO
	5.	3/1979	JP-A-54-037544	Japan			abs.	
	6.	8/1986	JP-A-61-185972	Japan			abs.	
	7.	1/1991	JP3022476	Japan			abs.	
	8.	2/1992	JP-A-04-053090	Japan			abs.	
	9.	6/1995	JP-A-07-161844	Japan			abs.	
	10.	5/1996	JP-A-07-176633	Japan			abs.	
	11.	8/1998	JP-A-10-222985	Japan			abs.	

OTHER DOCUMENTS   *(including author, title, Date, Pertinent Pages, Etc.)*

Examiner Initials	Ref. No.	Title
	12.	*"PRINCIPLES OF CMOS VLSI DESIGN"*, A Systems Perspective, Second Edition, , Neil H.E. Weste and Kamran Eshraghian, Chapter 10, pp 578-83, 1992
	13.	F. Assaderaghi et al., "Dynamic threshold-voltage MOSFET (DTMOS) for ultra-low voltage VLSI", IEEE Transactions on Electron Devices, vol. 44, no. 3, pp. 414-422, March 1997
	14.	Assaderaghi et al., 1994 "A dynamic threshold voltage MOSFET (DTMOS) for very low voltage operation" IEEE Electron Device Letters Vol. 15, pp 510-512.
	15.	Andoh et al., 1994 "Design methodology for low-voltage MOSFETS" IEEE International Electron Devices Meeting, Technical Digest, pp 79-82.
	16.	Assaderaghi et al., 1994 "A dynamic threshold voltage MOSFET (DTMOS) for ultra-low voltage operation" IEEE International Electron Devices Meeting, Technical Digest, pp 809-812.
	17.	David A. Hodges et al., "Analysis and design of digital integrated circuits", second edition, McGraw-Hill, Inc., PP 368-369; 1988

EXAMINER: *Douglas Wille*	1DATE CONSIDERED: *4 Feb 05*

EXAMINER: Initial if citation considered, whether or not the citation conforms with MPEP 609. Draw a line through the citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.